


<b>Search Notes</b> 	<b>Application/Control No.</b> 10537100	<b>Applicant(s)/Patent Under Reexamination</b> AKIYAMA ET AL.
	<b>Examiner</b> Shi K Li	<b>Art Unit</b> 2613

SEARCHED			
Class	Subclass	Date	Examiner
398	115	12/23/2008	SK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search	12/23/2008	SK
Updated search	5/7/2009	SK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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